


Search Notes		Application/Control No.	Applicant(s)/Patent under Reexamination	
		10/728,666	YOSHIOKA ET AL.	
		Examiner	Art Unit	
		Tae H. Yoon	1714	

SEARCHED			
Class	Subclass	Date	Examiner
427	96.1	8-27-06	zy
	98.8		
438	206		
	281		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
427	96.1	7/17/07	zy

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	8/24/06	zy
Inventor Search	8-29-06	zy
EAST	12-7-06	zy
EAST	5/18-07	zy
EAST	7/09/07	zy
EAST	7-17-07	zy